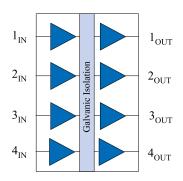
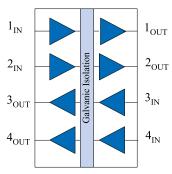
T-Series Wide Temperature Range High Speed Four Channel Digital Coupler

Functional Diagram

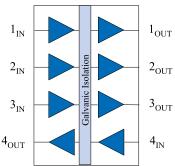
IL715



IL716



IL717



Isoloop® is a registered trademark of NVE Corporation

Features

- · Wide Temperature Range -40°C to +125°C
- · +5/3.3V CMOS/TTL Compatible
- · High Speed: 110 MBaud
- · 2500 V_{RMS} Isolation (1 min)
- · 2 ns Typical Pulse Width Distortion
- · 4 ns Typical Propagation Delay s Skew
- · 10 ns Typical Propagation Delay
- · 30 kV/µs Typical Transient Immunity
- · 2 ns Channel to Channel Skew
- · 0.3" and 0.15" 16-Pin SOIC Packages
- · UL1577 Approval Pending
- · IEC 61010-1 Approval Pending

Isolation Applications

- · ADCs and DACs
- · Digital Fieldbus
- * RS485 and RS422
- Multiplexed Data Transmission
- · Data Interfaces
- * Board-To-Board Communication
- · Digital Noise Reduction
- · Operator Interface
- Ground Loop Elimination
- · Peripheral Interfaces
- · Parallel Bus
- · Logic Level Shifting

Description

NVE's family of high-speed digital isolators are CMOS devices created by integrating active circuitry and our GMR-based and patented* IsoLoop* technology. The IL715, IL716 and IL717 T-Series of 4—channel digital couplers offer the user the widest temperature range available. All transmit and receive channels operate at 110 Mbd over the full temperature and supply voltage range. The symmetric magnetic coupling barrier provides a typical propagation delay of only 10 ns and a pulse width distortion of 2 ns achieving the best specifications of any isolator device. Typical transient immunity of 30 kV/µs is unsurpassed. The IL715 has four transmit channels; the IL716 has two transmit channels and two receive channels; the IL717 has three transmit channels and one receive channel. Their high channel density makes these devices ideally suited to isolating ADCs and DACs, parallel buses and peripheral interfaces.

The IL715, IL716 and IL717 are available in 0.3" and 0.15" 16-pin SOIC packages and performance is specified over the temperature range of -40°C to +125°C.

^{*} US Patent number 5,831,426; 6,300,617 and others.

$IL715/6/7T^{\text{IsoLoop}}$

Absolute Maximum Ratings

Parameters	Symbol	Min.	Max.	Units
Storage Temperature	T _S	-55	175	°C
Ambient Operating Temperature ⁽¹⁾	T _A	-55	135	°C
Supply Voltage	V_{DD1}, V_{DD2}	-0.5	7	Volts
Input Voltage	V _I	-0.5	V _{DD} +0.5	Volts
Output Voltage	V _O	-0.5	V _{DD} +0.5	Volts
Output Current Drive Channel	I _O		10	mA
Lead Solder Temperature (10s)			280	°C
ESD	2kV I	Human Body M	Model	

Recommended Operating Conditions

Parameters	Symbol	Min.	Max.	Units
Ambient Operating Temperature	T_A	-40	125	°C
Supply Voltage (3.3/5.0 V operation)	$V_{\mathrm{DD1}}, V_{\mathrm{DD2}}$	3.0	5.5	Volts
Logic High Input Voltage	V _{IH}	2.4	V_{DD}	Volts
Logic Low Input Voltage	V _{IL}	0	0.8	Volts
Minimum Signal Rise and Fall Times	$t_{\rm IR}, t_{\rm IF}$		1	μsec

Insulation Specifications

Parameter	Symbol	Min	Тур.	Max.	Units	Test Condition
Barrier Impedance				>1014 7		Ω pF
Creepage Distance (External)		8.077 (0.3" SOIC) 4.026 (0.15" SOIC)			mm	
Leakage Current			0.2		μΑ	240 V _{RMS}
Capacitance (Input-Output)(5)	C _{I-O}		4.0		pF	f=1MHz

<u>IEC61010-1</u>

TUV Certificate Numbers: Pending

Classification as Table 1.

Model	Pollution	Material	Max Working	Package Type	
	Degree	Group	Voltage	16-SOIC (0.3")	16-SOIC (0.15")
IL715, IL716, IL717	II	III	300 Vrms	✓	
IL715-3, IL716-6, IL717-3	II	III	150 Vrms		✓

<u>UL 1577</u>

Component Recognition program. File # Pending

Rated 2500Vrms for 1min.

Electrical Specifications

Electrical Specifications are T_{min} to T_{max}

Parameter	Symbol	3.0-3.6	V Specifi	cations	4.5-5.	5 V Specif	fications	Units	Test Conditions
DC Specifications	3,000,00	Min.	Typ.	Max.	Min.	Typ.	Max.		
Input Quiescent Supply Current						**			
IL715	I_{DD1}		16	20		24	30	μΑ	
IL716	I_{DD1}		3.3	4		5	6	mA	
IL717	I_{DD1}		1.5	2.0		2.5	3.0	mA	
Output Quiescent Supply Current									
IL715	I_{DD2}		5.5	8		8	12	mA	
IL716	I_{DD2}		3.3	4		5	6	mA	
IL717	I_{DD2}		3	6		6	9	mA	
Logic Input Current	I _I	-10		10	-10		10	μΑ	
Logic High Output Voltage	V _{OH}	V _{DD} -0.1	V_{DD}		$V_{\rm DD}$ -0.1	V_{DD}		V	$I_{O} = -20 \mu A, V_{I} = V_{IH}$
		$0.8*V_{DD}$	V_{DD} -0.5		$0.8*V_{\mathrm{DD}}$	V_{DD} -0.5			$I_O = -4 \text{ mA}, V_I = V_{IH}$
Logic Low Output Voltage	V _{OL}		0	0.1		0	0.1	V	$I_0 = 20 \mu A, V_I = V_{II}$
	OE		0.5	0.8		0.5	0.8		$I_O = 4 \text{ mA}, V_I = V_{IL}$
Switching Parameters									-
Dynamic Current Consumption ⁽⁶⁾ (per channel)		300	420			500	640	μA/MHz	
Maximum Data Rate		100	110		100	110		MBd	$C_{L} = 15 \text{ pF}$
Minimum Pulse Width	PW	100	110		100	110		ns	50% Points, V _O
Propagation Delay	1 **	10			10			113	3070101113, 10
Input to Output (High to Low)	t _{PHL}		12	18		10	15	ns	$C_L = 15 \text{ pF}$
Propagation Delay Input to Output (Low to High)	t _{PLH}		12	18		10	15	ns	$C_L = 15 \text{ pF}$
Pulse Width Distortion ⁽²⁾ tPHL- tPLH	PWD		2	3		2	3	ns	$C_L = 15 \text{ pF}$
Propagation Delay Skew ⁽³⁾	t _{PSK}		4	6		4	6	ns	$C_L = 15 \text{ pF}$
Output Rise Time (10-90%)	t _R		2	4		1	3	ns	$C_L = 15 \text{ pF}$
Output Fall Time (10-90%)	t _F		2	4		1	3	ns	$C_L = 15 \text{ pF}$
Common Mode Transient Immunity (Output Logic High or Logic Low) ⁽⁴⁾	CMH	20	30		20	30		kV/μs	Vcm = 300V
Channel to Channel Skew	t _{CSK}		2	3		2	3	ns	$C_{L} = 15 \text{ pF}$

Notes:

- Absolute Maximum ambient operating temperature means the device will not be damaged if operated under these conditions. It does not guarantee performance.
- 2. PWD is defined as $|t_{PHL}-t_{PLH}|$. %PWD is equal to the PWD divided by the pulse width.
- 3. t_{PSK} is equal to the magnitude of the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between units at 25°C.
- 4. $\rm CM_H$ is the maximum common mode voltage slew rate that can be sustained while maintaining $\rm V_O > 0.8~V_{DD}$. $\rm CM_L$ is the maximum common mode input voltage that can be sustained while maintaining $\rm V_O < 0.8~V$. The common mode voltage slew rates apply to both rising and falling common mode voltage edges.
- 5. Device is considered a two terminal device: pins 1-8 shorted and pins 9-16 shorted.
- 6. Dynamic current is consumed on the supply side with data inputs only. See table below for the typical total dynamic current for each device type at 3.3Volts.

Type	VDD1	VDD2	Units
715	1200	0	μA/MHz
716	600	600	μA/MHz
717	900	300	μA/MHz

IL715/6/7T

Application Notes:

Dynamic Power Consumption

Isoloop® devices achieve their low power consumption from the manner by which they transmit data across the isolation barrier. By detecting the edge transitions of the input logic signal and converting these to narrow current pulses, a magnetic field is created around the GMR Wheatstone bridge. Depending on the direction of the magnetic field, the bridge causes the output comparator to switch following the input logic signal. Power consumption is independent of mark-to-space ratio and solely dependent on frequency. This has obvious advantages over optocouplers whose power consumption is heavily dependent on its on-state and frequency.

The maximum power supply current per channel for Isoloop is:

$$I(input) = 40 \left(\frac{f}{fmax}\right) \left(\frac{4}{5}\right) mA$$

where f = operating frequencyfmax = 50 MHz

Power Supply Decoupling

Both power supplies to these devices should be decoupled with low ESR 100 nF ceramic capacitors. For data rates in excess of 10MBd, use of ground planes for both GND1 and GND2 is highly recommended. Capacitors should be located as close as possible to the device.

Signal Status on Start-up and Shut Down

To minimize power dissipation, the input signals are differentiated and then latched on the output side of the isolation barrier to reconstruct the signal. This could result in an ambiguous output state depending on power up, shutdown and power loss sequencing. Therefore, the designer should consider the inclusion of an initialization signal in his start-up circuit. Initialization consists of toggling each channel either high then low or low then high, depending on the desired state.

Electrostatic Discharge Sensitivity

This product has been tested for electrostatic sensitivity to the limits stated in the specifications. However, NVE recommends that all integrated circuits be handled with appropriate care to avoid damage. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.

Data Transmission Rates

The reliability of a transmission system is directly related to the accuracy and quality of the transmitted digital information. For a digital system, those parameters which determine the limits of the data transmission are *pulse width distortion* and *propagation delay skew*

Propagation delay is the time taken for the signal to travel through the device. This is usually different when sending a low-to-high than when sending a high-to-low signal. This difference, or error, is called pulse width distortion (PWD) and is usually in ns. It may also be expressed as a percentage:

For example: For data rates of 12.5 Mb

$$PWD\% = \frac{3 \text{ ns}}{80 \text{ ns}} \times 100\% = 3.75\%$$

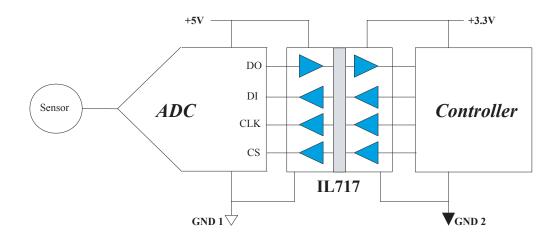
This figure is almost *three times* better than for any available optocoupler with the same temperature range, and *two times* better than any optocoupler regardless of published temperature range. The *IsoLoop** range of isolators surpasses the 10% maximum PWD recommended by PROFIBUS, and will run at almost 35 Mb before reaching the 10% limit.

Propagation delay skew is the difference in time taken for two or more channels to propagate their signals. This becomes significant when clocking is involved since it is undesirable for the clock pulse to arrive before the data has settled. A short propagation delay skew is therefore critical, especially in high data rate parallel systems, to establish and maintain accuracy and repeatability. The *IsoLoop*® range of isolators all have a maximum propagation delay skew of 6 ns, which is *five times* better than any optocoupler. The maximum channel to channel skew in the IsoLoop® coupler is only 3 ns which is *ten times* better than any optocoupler.

IL715/6/7T

Applications:

Isolated Logic Level Shifters

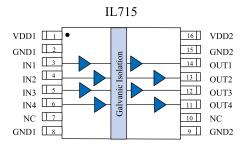


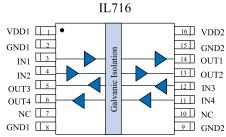
IL715/6/7T

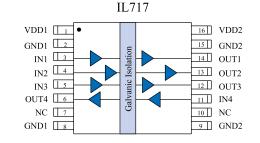
Pin Configurations IL715, IL716, IL717

Note: Connected Internally

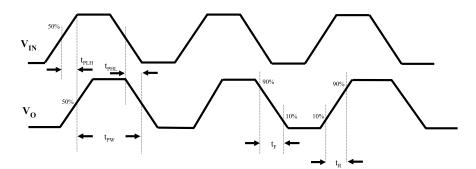
Pins 2 & 8 Pins 9 & 15







Timing Diagram

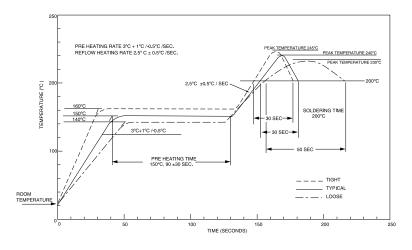


Legend

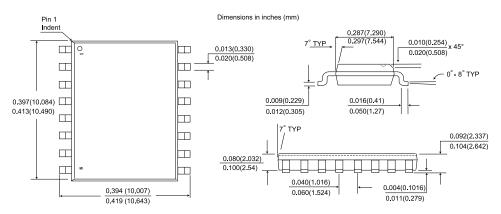
$t_{\rm PLH}$	Propagation Delay, Low to High
t_{PHL}	Propagation Delay, High to Low
t_{PW}	Minimum Pulse Width
t_R	Rise Time
$t_{\scriptscriptstyle E}$	Fall Time

IR Soldering Profile

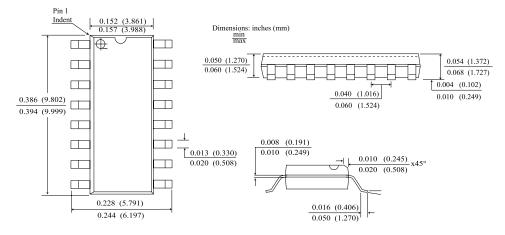
Recommended profile shown. Maximum temperature allowed on any profile is 260° C.



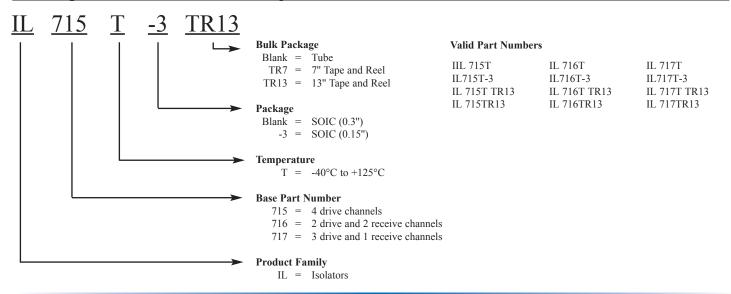
0.3" SOIC-16 Package



0.15" SOIC-16 Package



Ordering Information: use the following format to order these devices



About NVE

NVE Corporation is a world leader in the practical commercialization of "spintronics," which many experts believe represents the next generation of microelectronics — the successor to the transistor. Unlike conventional electronics, which rely on electron charge, spintronics uses electron spin to store and transmit information. Spintronics devices are smaller, faster, and more accurate, compared to charge-based microelectronics.

It is the spin of electrons that causes magnetism. NVE's products use proprietary spintronic materials called Giant Magnetoresistors (GMR). These materials are made of exotic alloys a few atoms thick, and provide very large signals (the "Giant" in "Giant Magnetoresistor"). NVE has the unique capability to combine leading edge GMR materials with integrated circuits to make high performance electronic components.

We are pioneers in creating practical products using this revolutionary technology and introduced the world's first GMR products in 1994. We also license spintronics/Magnetic Random Access Memory (MRAM) designs to world-class memory manufacturers.

Our products include:

- · Digital Signal Isolators
- · Isolated Bus Transceivers
- · Magnetic Field Sensors
- · Magnetic Field Gradient Sensors (Gradiometer)
- · Digital Magnetic Field Sensors.

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Specifications shown are subject to change without notice.

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